

# **BSS84**

# P-channel enhancement mode vertical DMOS transistor Rev. 06 — 16 December 2008 Product data

**Product data sheet** 

## 1. Product profile

## 1.1 General description

P-channel enhancement mode vertical Diffusion Metal-Oxide Semiconductor (DMOS) transistor in a small Surface-Mounted Device (SMD) plastic package.

Table 1. Product overview

Type number[1]	Package	
	NXP	JEDEC
BSS84	SOT23	TO-236AB
BSS84/DG		

<sup>[1] /</sup>DG: halogen-free

## 1.2 Features

Low threshold voltage

High-speed switching

Direct interface to CMOS and Transistor-Transistor Logic (TTL)

No secondary breakdown

## 1.3 Applications

■ Line current interrupter in telephone sets ■ Relay, high-speed and line transformer drivers

## 1.4 Quick reference data

 $V_{DS} \le -50 \text{ V}$ 

 $\blacksquare$  R<sub>DSon</sub>  $\leq$  10  $\Omega$ 

 $I_D \le -130 \text{ mA}$ 

Arr P<sub>tot</sub>  $\leq$  250 mW



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001aaa025

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#### **Pinning information** 2.

Table 2. **Pinning** 

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		_
2	S	source	3	D
3	D	drain	1	G

#### **Ordering information** 3.

Ordering information Table 3.

Type number[1]					
	Name	Description	Version		
BSS84	TO-236AB	plastic surface-mounted package; 3 leads	SOT23		
BSS84/DG					

<sup>[1] /</sup>DG: halogen-free

# **Marking**

**Product data sheet** 

Table 4. **Marking codes** 

Type number[1]	Marking code <sup>[2]</sup>
BSS84	13*
BSS84/DG	ZV*

<sup>[1] /</sup>DG: halogen-free

[2] \* = -: made in Hong Kong

\* = p: made in Hong Kong

\* = t: made in Malaysia

\* = W: made in China

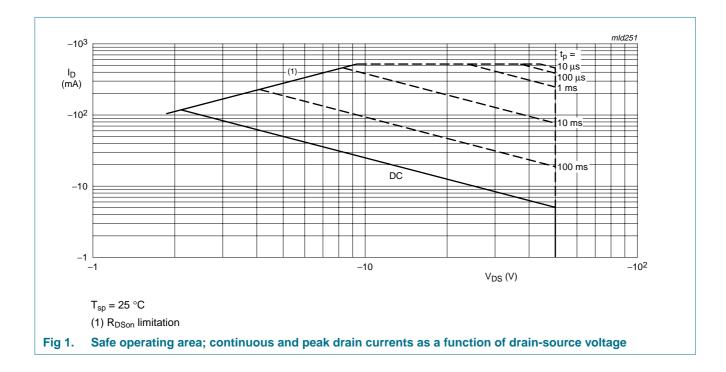
## P-channel enhancement mode vertical DMOS transistor

# 5. Limiting values

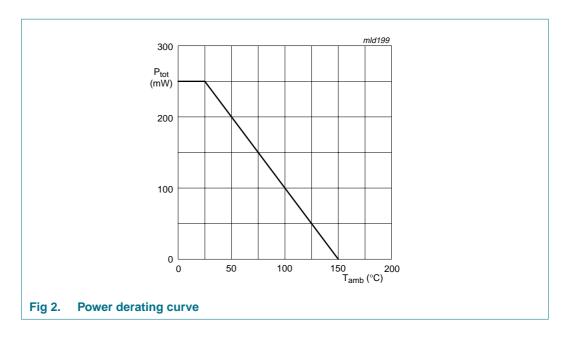
**Table 5.** Limiting values
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage	25 °C $\leq$ T $_{j}$ $\leq$ 150 °C	-	-50	V
$V_{GS}$	gate-source voltage		-	±20	V
$I_D$	drain current	$T_{sp} = 25 ^{\circ}\text{C}; V_{GS} = -10 \text{V};$ see Figure 1	-	-130	mA
		T <sub>sp</sub> = 100 °C; V <sub>GS</sub> = -10 V	-	<del>-</del> 75	mA
I <sub>DM</sub>	peak drain current	$T_{sp} = 25 ^{\circ}C; t_p \le 10 \mu s;$ see Figure 1	-	-520	mA
P <sub>tot</sub>	total power dissipation	T <sub>sp</sub> = 25 °C; see <u>Figure 2</u>	[1] -	250	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		-65	+150	°C

<sup>[1]</sup> Device mounted on a Printed-Circuit Board (PCB).



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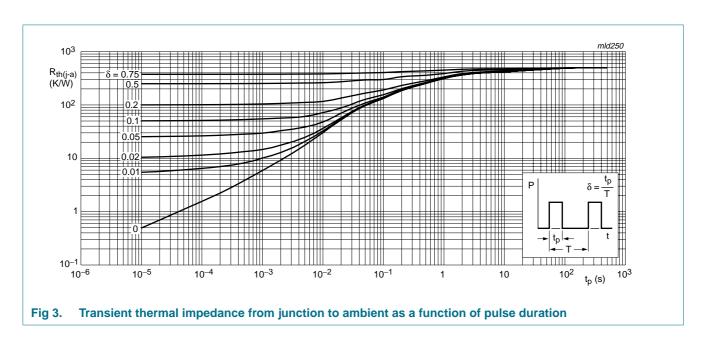


## 6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	see Figure 3	[1] -	-	500	K/W

<sup>[1]</sup> Mounted on a PCB, vertical in still air.



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## 7. Characteristics

Table 7. Characteristics

 $T_i = 25 \,^{\circ}C$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = -10 \ \mu A; \ V_{GS} = 0 \ V$	-50	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = -1 \text{ mA}; V_{DS} = V_{GS};$ see Figure 8				
		T <sub>j</sub> = 25 °C	-0.8	-	-2	V
		T <sub>j</sub> = −55 °C	-	-	-1.8	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = -40 \text{ V}; V_{GS} = 0 \text{ V}$				
		T <sub>j</sub> = 25 °C	-	-	-100	nΑ
		$V_{DS} = -50 \text{ V}; V_{GS} = 0 \text{ V}$				
		T <sub>j</sub> = 25 °C	-	-	-10	μΑ
		T <sub>j</sub> = 125 °C	-	-	-60	μΑ
I <sub>GSS</sub> gate leakage current	gate leakage current	$V_{GS} = +20 \text{ V}; V_{DS} = 0 \text{ V}$	-	-	100	nΑ
		$V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}$	-	-	100	nΑ
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = -10 \text{ V};$ $I_D = -130 \text{ mA};$ see Figure 5 and 7	-	6	10	Ω
Dynamic o	characteristics					
Y <sub>fs</sub>	transfer admittance	$V_{DS} = -25 \text{ V};$ $I_D = -130 \text{ mA}$	50	-	-	mS
C <sub>iss</sub>	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = -25 \text{ V};$	-	25	45	pF
Coss	output capacitance	f = 1 MHz; see Figure 9	-	15	25	pF
C <sub>rss</sub>	reverse transfer capacitance		-	3.5	12	pF
t <sub>on</sub>	turn-on time	$V_{DS} = -40 \text{ V}; V_{GS} = 0 \text{ V}$ to -10 V; $I_{D} = -200 \text{ mA};$ see <u>Figure 10</u> and <u>11</u>	-	3	-	ns
t <sub>off</sub>	turn-off time	$V_{DS} = -40 \text{ V};$ $V_{GS} = -10 \text{ V to 0 V};$ $I_D = -200 \text{ mA};$ see Figure 10 and 11	-	7	-	ns

## P-channel enhancement mode vertical DMOS transistor

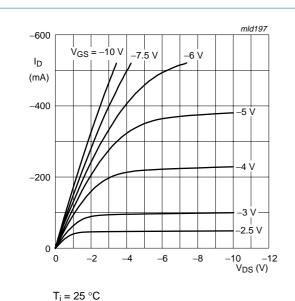
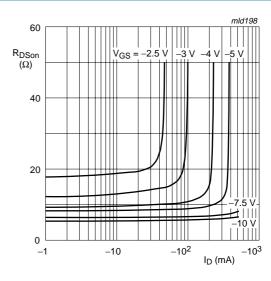


Fig 4. Output characteristics: drain current as a function of drain-source voltage; typical values



T<sub>j</sub> = 25 °C

Fig 5. Drain-source on-state resistance as a function of drain current; typical values

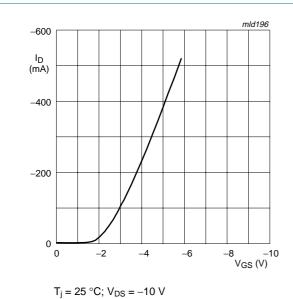
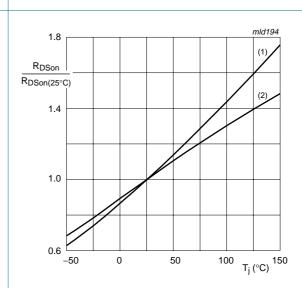


Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values



(1)  $I_D = -130$  mA;  $V_{GS} = -10$  V

(2)  $I_D = -20 \text{ mA}$ ;  $V_{GS} = -2.4 \text{ V}$ 

Fig 7. Normalized drain-source on-state resistance factor as a function of junction temperature

## P-channel enhancement mode vertical DMOS transistor

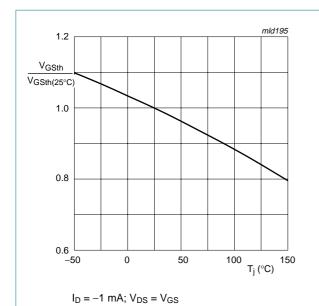
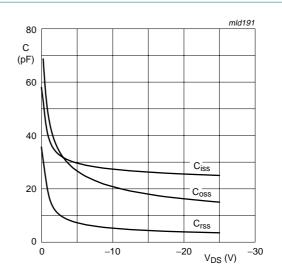


Fig 8. Gate-source threshold voltage as a function of junction temperature



 $V_{GS} = 0 V$ ; f = 1 MHz

Fig 9. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

## 8. Test information

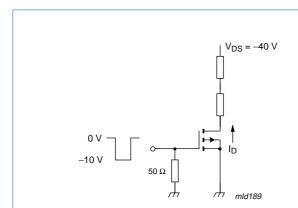


Fig 10. Switching time test circuit

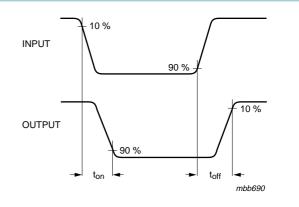


Fig 11. Input and output waveforms

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# 9. Package outline

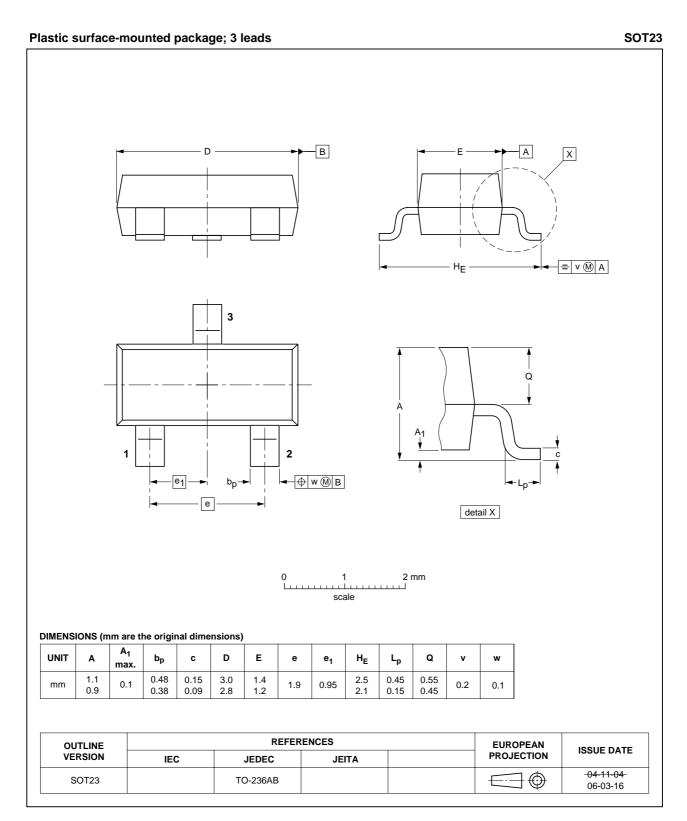


Fig 12. Package outline SOT23 (TO-236AB)

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## P-channel enhancement mode vertical DMOS transistor

# 10. Revision history

## Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BSS84_6	20081216	Product data sheet	-	BSS84_5
Modifications:	<ul> <li>Table 5 "Limit</li> </ul>	ing values": P <sub>tot</sub> figure referen	ce updated	
BSS84_5	20081209	Product data sheet	-	BSS84_4
BSS84_4	20070717	Product data sheet	-	BSS84_3
BSS84_3	20030804	Product specification	-	BSS84_2
BSS84_2	19970618	Product specification	-	BSS84_1
BSS84_1	19950407	Product specification	-	-

#### P-channel enhancement mode vertical DMOS transistor

## 11. Legal information

#### 11.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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